

Search Notes



Application/Control No.

10/810,324

Examiner

Tien Dinh

Applicant(s)/Patent under Reexamination

HENLEY ET AL.

Art Unit

3644

SEARCHED

Class	Subclass	Date	Examiner
244	118.5		
	118.6	11/05	JD
297	217.3	11/05	JD
439	110		
	112		
	121	11/05	JD

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Smr		11/05	JD
2			
abw/ke			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Est Text	11/05	JD